(Following Paper ID and Roll No. to be filled in your Answer Book)

PAPER ID: 3071 Roll No.

B.Tech.

(SEM. III) ODD SEMESTER THEORY EXAMINATION 2010-11

PULSE AND DIGITAL ELECTRONICS

Time: 3 Hours Total Marks: 100

Note: - Attempt all questions. All questions carry equal marks.

- 1. Attempt any two parts of the following: (10×2=20)
 - (a) Draw the circuit diagram of NMOS NOR gate and explain its operation. Why power dissipation in an NMOS NAND gate is lower than that of NMOS NOR gate ? Explain.
 - (b) Simplify the given function using tabular method $F(A, B, C, D, E, F, G) = \Sigma (20,28,38,39,52,60,102,103,127)$. Also implement the simplified function using basic gates.
 - (c) Simplify the given function using Karnough Map:

F (A, B, C, D) =
$$\Sigma$$
 (0, 2, 3, 6, 7)
d (5, 8, 10, 11, 15).

Also implement the simplified function using universal gates only.

- 2. Attempt any four parts of the following: $(5\times4=20)$
 - (a) Subtract 68 from 61 using BCD. Show all the steps.

- (b) Desing Full Subtractor. Also show truth table and circuit diagram.
- (c) Design a 3-bit magnitude comparator.
- Design a full adder using 8: 1 multiplexer.
- (e) Implement the following function using PLA:

$$F_{\bullet}(A, B, C) = \Sigma(0, 1, 6, 7)$$

$$F_{\bullet}(A, B, C) = \Sigma (1, 2, 4, 6)$$

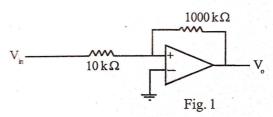
(f) A combinational circuit is defined by the following Boolean functions. Design circuit with a decoder and external

$$Y = \overline{A} \overline{B} \overline{C} + AC$$

$$Y_2 = A \overline{B} C + \overline{A}C$$
.

- Attempt any four parts of the following: (5×4=20)
 - (a) What is the difference between a latch and a flip-flop?
 How basic latch operation is performed by NOT gates?
 - (b) Convert D flip-flop to T flip-flop.
 - (c) Design universal shift register.
 - (d) Design a Mod-5 synchronous counter.
 - (e) Design a four-stage Johnson Counter.
 - (f) Draw waveforms to illustrate how a serial binary number 1011 is loaded into a shift register.

- 4. Attempt any four parts of the following: $(5\times4=20)$
 - (a) With the help of figure explain the operation of a bipolar SRAM cell and MOS SRAM cell.
 - (b) Explain basic semiconductor memory organization with the help of figure.
 - (c) Explain the working of dual slope ADC.
 - (d) Explain the operation of basic sample and hold circuit. Also state the advantages and applications of sample and hold circuits.
 - (e) What is attenuator? Explain the under and over compensation in attenuators.
 - (f) Derive and draw the response of low pass RC circuit to step and sinusoidal waveforms.
- 5. Attempt any four parts of the following: (5×4=20)
 - (a) With reference to a PLL, define:
 - (i) Caputure range
 - (ii) Lock range
 - (iii) Pull in time.
 - (b) For a noninverting regenerative comparator shown in Fig.1, calculate tripping voltages. Assume V_{sat} = ±12 V



- (c) Design a monostable for a pulse width of 10 ms by using IC 555.
- (d) Explain the working of IC 555 as an astable multivibrator with neat diagram.
- (e) Design an adjustable voltage regulator using IC 7805 to give variable output voltage from +5 V to +8 V with $I_1 = 1$ A.
- (f) Draw the diagram of series and shunt regulators and explain the working.